

# **SWITCHMODE**<sup>TM</sup>

# NPN Bipolar Power Transistor For Switching Power Supply Applications

The BUL44 have an applications specific state-of-the-art die designed for use in 220 V line operated Switchmode Power supplies and electronic light ballasts. These high voltage/high speed transistors offer the following:

• Improved Efficiency Due to Low Base Drive Requirements:

High and Flat DC Current Gain hFE

Fast Switching

No Coil Required in Base Circuit for Turn-Off (No Current Tail)

- Full Characterization at 125°C
- Tight Parametric Distributions are Consistent Lot-to-Lot

### **MAXIMUM RATINGS**

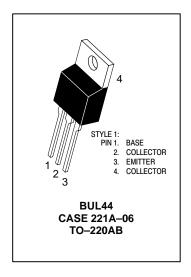
Rating	Symbol	Value	Unit
Collector–Emitter Sustaining Voltage	VCEO	400	Vdc
Collector–Emitter Breakdown Voltage	VCES	700	Vdc
Emitter–Base Voltage	VEBO	9.0	Vdc
Collector Current — Continuous — Peak(1)	I <sub>C</sub>	2.0 5.0	Adc
Base Current — Continuous — Peak(1)	I <sub>B</sub> I <sub>BM</sub>	1.0 2.0	Adc
Total Device Dissipation $(T_C = 25^{\circ}C)$ Derate above 25°C	PD	50 0.4	Watts W/°C
Operating and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	- 65 to 150	°C

#### THERMAL CHARACTERISTICS

Rating	Symbol	Max	Unit
Thermal Resistance — Junction to Case — Junction to Ambient	$R_{ hetaJC}$	2.5 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	TL	260	°C

# **BUL44**

POWER TRANSISTOR 2.0 AMPERES 700 VOLTS 40 and 100 WATTS



## BUL44

# **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

, •	•				
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Collector–Emitter Sustaining Voltage (I <sub>C</sub> = 100 mA, L = 25 mH)	VCEO(sus)	400	_	_	Vdc
Collector Cutoff Current (V <sub>CE</sub> = Rated V <sub>CEO</sub> , I <sub>B</sub> = 0)	ICEO	_	_	100	μAdc
Collector Cutoff Current (VCE = Rated VCES, VEB = 0)	ICES	_	_	100	μAdc
$(T_C = 125^{\circ}C)$		_	_	500	
$(V_{CE} = 500 \text{ V}, V_{EB} = 0)  (T_{C} = 125^{\circ}\text{C})$		_	_	100	
Emitter Cutoff Current (V <sub>EB</sub> = 9.0 Vdc, I <sub>C</sub> = 0)	I <sub>EBO</sub>	_	_	100	μAdc

# ON CHARACTERISTICS

Base–Emitter Saturation Voltage ( $I_C = 0.4$ Adc, $I_B = (I_C = 1.0$ Adc, $I_B = 0.0$	V <sub>BE</sub> (sat)		0.85 0.92	1.1 1.25	Vdc	
Collector–Emitter Saturation Voltage	VCE(sat)		0.00	0.5	Vdc	
$(I_C = 0.4 \text{ Adc}, I_B = 40 \text{ mAdc})$	(T 40500)		_	0.20	0.5	
(	$(T_C = 125^{\circ}C)$		_	0.20	0.5	
$(I_C = 1.0 \text{ Adc}, I_B = 0.2 \text{ Adc})$			_	0.25	0.6	
	$(T_C = 125^{\circ}C)$		_	0.25	0.6	
DC Current Gain		hFE				_
$(I_C = 0.2 \text{ Adc}, V_{CE} = 5.0 \text{ Vdc})$			14	_	34	
	$(T_C = 125^{\circ}C)$		_	32	_	
$(I_C = 0.4 \text{ Adc}, V_{CF} = 1.0 \text{ Vdc})$			12	20	_	
, ,	$(T_C = 125^{\circ}C)$		12	20	_	
$(I_C = 1.0 \text{ Adc}, V_{CF} = 1.0 \text{ Vdc})$	, ,		8.0	14	_	
, , , , , , , , , , , , , , , , , , , ,	$(T_{C} = 125^{\circ}C)$		7.0	13	_	
(I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 5.0 Vdc)	,		10	22	_	

# **DYNAMIC CHARACTERISTICS**

	-							
Current Gain Bandwidth (I <sub>C</sub> = 0.5 Adc, V <sub>CE</sub> = 10 Vdc, f = 1.0 MHz)				fT	_	13	_	MHz
Output Capacitance (V <sub>CB</sub> = 10 Vdc, I <sub>E</sub> = 0, f = 1.0 MHz)			put Capacitance (V <sub>CB</sub> = 10 Vdc, I <sub>E</sub> = 0, f = 1.0 MHz)		_	38	60	pF
Input Capacitance (V <sub>EB</sub> = 8.0	Input Capacitance (V <sub>EB</sub> = 8.0 V)			C <sub>IB</sub>	_	380	600	pF
Dynamic Saturation Voltage: Determined 1.0 μs and 3.0 μs respectively after rising I <sub>B1</sub> reaches 90% of	(IC = 0.4 Adc	1.0 μs	(T <sub>C</sub> = 125°C)	v	_	2.5 2.7	_	
	I <sub>B1</sub> = 40 mAdc V <sub>CC</sub> = 300 V)	3.0 μs	(T <sub>C</sub> = 125°C)		_	1.3 1.15	_	.,,
		-	(T <sub>C</sub> = 125°C)	VCE(dsat)	_	3.2 7.5	_	Vdc
final I <sub>B1</sub>	$I_{B1} = 0.2 \text{ Adc}$ $V_{CC} = 300 \text{ V}$	3.0 μs	(T <sub>C</sub> = 125°C)		_	1.25 1.6	_	

<sup>(1)</sup> Pulse Test: Pulse Width = 5.0 ms, Duty Cycle ≤ 10%.

(continued)

# BUL44

# SWITCHING CHARACTERISTICS: Resistive Load (D.C. $\leq$ 10%, Pulse Width = 20 $\mu$ s)

 $(I_C = 0.8 \text{ Adc}, I_{B1} = 160 \text{ mAdc} \\ I_{B2} = 160 \text{ mAdc})$ 

Storage Time

**Crossover Time** 

Fall Time

Storage Time

Crossover Time

	•		• ,				
Turn-On Time	(I <sub>C</sub> = 0.4 Adc, I <sub>B1</sub> = 40 mAdc I <sub>B2</sub> = 0.2 Adc, V <sub>CC</sub> = 300 V)	(T <sub>C</sub> = 125°C)	<sup>t</sup> on		40 40	100 —	ns
Turn-Off Time	$(I_C = 0.4 \text{ Adc}, I_{B1} = 40 \text{ mAdc})$ $I_{B2} = 0.2 \text{ Adc}, V_{CC} = 300 \text{ V})$	(T <sub>C</sub> = 125°C)	<sup>t</sup> off	1 1	1.5 2.0	2.5 —	μs
Turn-On Time	(I <sub>C</sub> = 1.0 Adc, I <sub>B1</sub> = 0.2 Adc I <sub>B1</sub> = 0.5 Adc, V <sub>CC</sub> = 300 V)	(T <sub>C</sub> = 125°C)	<sup>t</sup> on		85 85	150 —	ns
Turn-Off Time	(I <sub>C</sub> = 1.0 Adc, I <sub>B1</sub> = 0.2 Adc I <sub>B2</sub> = 0.5 Adc, V <sub>CC</sub> = 300 V)	(T <sub>C</sub> = 125°C)	<sup>t</sup> off	1 1	1.75 2.10	2.5 —	μs
SWITCHING CHARACT	SWITCHING CHARACTERISTICS: Inductive Load ( $V_{clamp}$ = 300 V, $V_{CC}$ = 15 V, L = 200 $\mu$ H)						
Fall Time	$(I_C = 0.4 \text{ Adc}, I_{B1} = 40 \text{ mAdc})$ $I_{B2} = 0.2 \text{ Adc})$	(T <sub>C</sub> = 125°C)	<sup>t</sup> fi	1 1	125 120	200 —	ns
Storage Time		(T <sub>C</sub> = 125°C)	t <sub>Si</sub>		0.7 0.8	1.25 —	μs
Crossover Time		(T <sub>C</sub> = 125°C)	t <sub>C</sub>	_ _	110 110	200 —	ns
Fall Time	(I <sub>C</sub> = 1.0 Adc, I <sub>B1</sub> = 0.2 Adc I <sub>B2</sub> = 0.5 Adc)	(T <sub>C</sub> = 125°C)	<sup>t</sup> fi	_	110 120	175 —	ns

 $(T_C = 125^{\circ}C)$ 

 $t_{Si}$ 

 $t_{\mathsf{C}}$ 

tfi

tsi

 $t_{\text{C}}$ 

1.7

2.25

180

210

180

4.2

190

350

70

2.6

2.75

300

170

3.8

300

μs

ns

ns

μs

ns

### TYPICAL STATIC CHARACTERISTICS

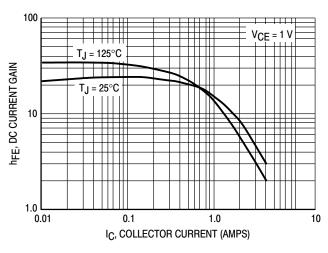


Figure 1. DC Current Gain at 1 Volt

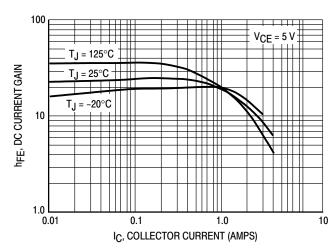


Figure 2. DC Current Gain at 5 Volts

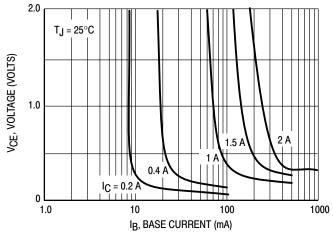


Figure 3. Collector Saturation Region

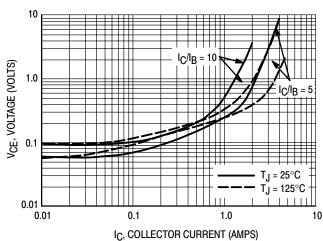


Figure 4. Collector-Emitter Saturation Voltage

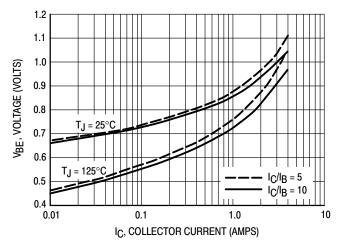


Figure 5. Base-Emitter Saturation Region

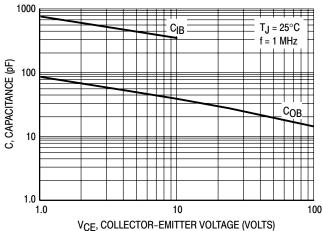
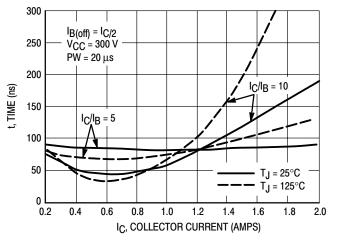


Figure 6. Capacitance

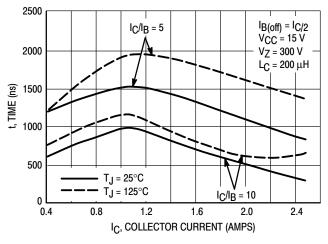
# TYPICAL SWITCHING CHARACTERISTICS (IB2 = IC/2 for all switching)



6.0  $I_{B(off)} = I_{C/2}$  $V_{CC} = 300 \text{ V}$ 5.0 IC/IB = 5 $PW = 20 \mu s$ 4.0 t, TIME (µs) T<sub>J</sub> = 25°C 3.0 Tj = 125°C 2.0 1.0  $I_C/I_B = 10$ 0.2 0.4 0.8 1.0 1.2 1.4 1.6 1.8 2.0 IC, COLLECTOR CURRENT (AMPS)

Figure 7. Resistive Switching, ton

Figure 8. Resistive Switching, toff



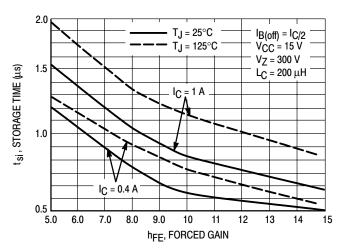
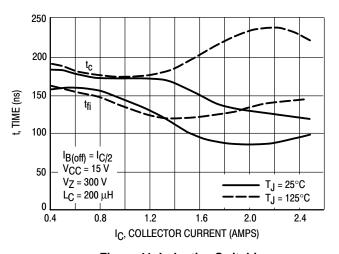


Figure 9. Inductive Storage Time, tsi

Figure 10. Inductive Storage Time



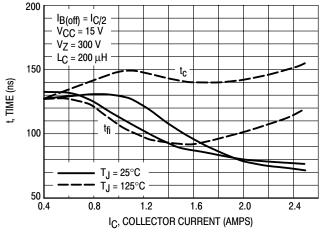


Figure 11. Inductive Switching,  $t_C$  and  $t_{fi}$   $I_C/I_B = 5$ 

Figure 12. Inductive Switching, t<sub>C</sub> and t<sub>fi</sub> I<sub>C</sub>/I<sub>B</sub> = 10

# TYPICAL SWITCHING CHARACTERISTICS (IB2 = IC/2 for all switching)

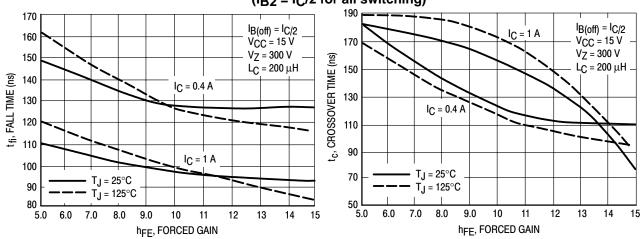


Figure 13. Inductive Fall Time

**Figure 14. Inductive Crossover Time** 

### **GUARANTEED SAFE OPERATING AREA INFORMATION**

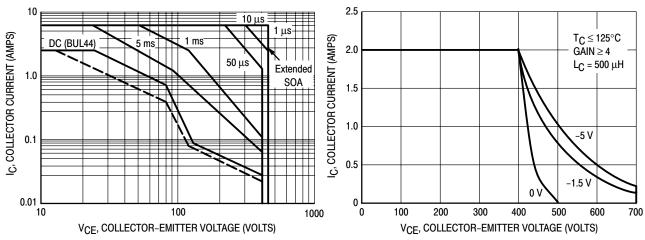


Figure 15. Forward Bias Safe Operating Area

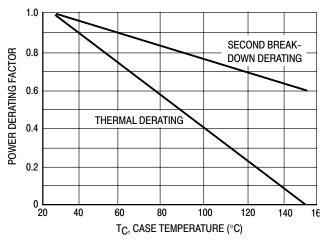


Figure 17. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_{C}$ – $V_{CE}$ 

Figure 16. Reverse Bias Switching Safe Operating Area

limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of figure 15 is based on  $T_C = 25$ °C;  $T_{J(PK)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C > 25$ °C. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on figure 15 may be found at any case temperature by using the appropriate curve on figure 17. TJ(PK) may be calculated from the data in figure 20. At any case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base-to-emitter junction reverse-biased. The safe level is specified as a reverse-biased safe operating area (Figure 16). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

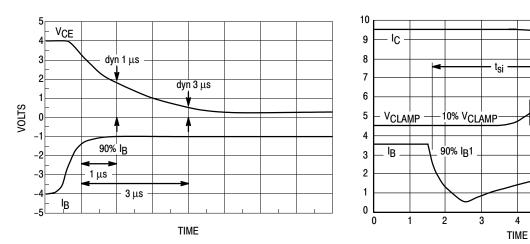


Figure 18. Dynamic Saturation Voltage Measurements

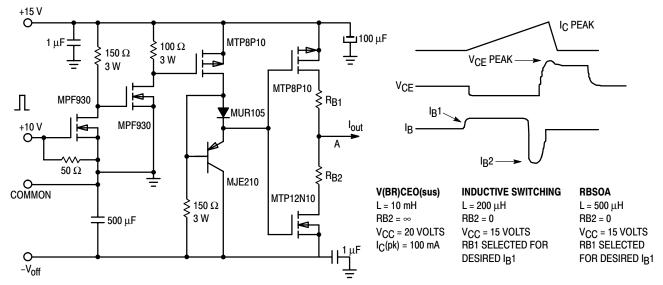
Figure 19. Inductive Switching Measurements

5

6

90% IC

10% I<sub>C</sub>



**Table 1. Inductive Load Switching Drive Circuit** 

### TYPICAL THERMAL RESPONSE

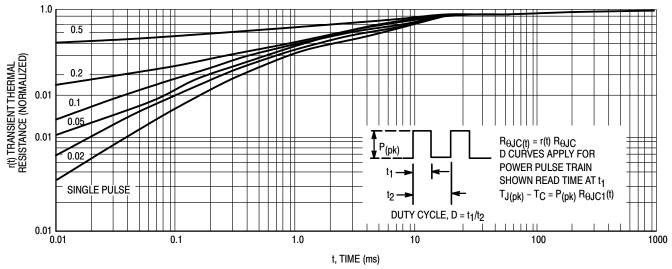
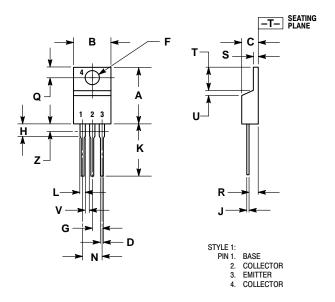


Figure 20. Typical Thermal Response ( $Z_{\theta JC}(t)$ ) for BUL44

### BUL44

### PACKAGE DIMENSIONS

### TO-220AB **CASE 221A-09 ISSUE AA**



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- Y 14.5M, 1982.
  CONTROLLING DIMENSION: INCH.
  DIMENSION Z DEFINES A ZONE WHERE ALL
  BODY AND LEAD IRREGULARITIES ARE
  ALLOWED.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
C	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	
7	0.018	0.025	0.46	0.64	
K	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
ø	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
s	0.045	0.055	1.15	1.39	
Т	0.235	0.255	5.97	6.47	
5	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z		0.080		2.04	

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